

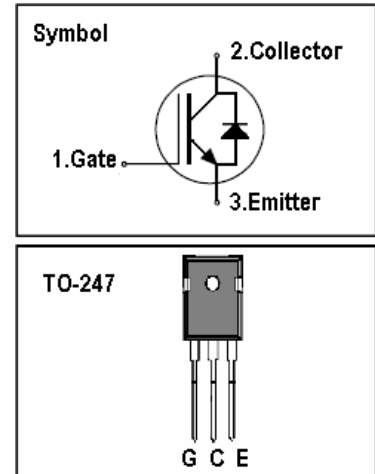
IGBT

Features

- 600V,60A
- $V_{CE(sat)(typ.)}=2.4V@V_{GE}=15V,I_C=60A$
- High speed switching
- Higher system efficiency
- Soft current turn-off waveforms
- Square RBSOA using NPT technology

General Description

JIAEN Trench IGBTs offer lower losses and higher energy efficiency for application such as SMPS, general inverter and other soft switching applications.



Absolute Maximum Ratings

Symbol	Parameter	Value	Units
V_{CES}	Collector-Emitter Voltage	600	V
V_{GES}	Gate-Emitter Voltage	± 30	V
I_C	Continuous Collector Current ($T_C=25^\circ C$)	120	A
	Continuous Collector Current ($T_C=100^\circ C$)	60	A
I_{CM}	Pulsed Collector Current (Note 1)	180	A
I_F	Diode Continuous Forward Current ($T_C=100^\circ C$)	60	A
I_{FM}	Diode Maximum Forward Current (Note 1)	180	A
t_{sc}	Short Circuit Withstand Time	10	us
P_D	Maximum Power Dissipation ($T_C=25^\circ C$)	310	W
	Maximum Power Dissipation ($T_C=100^\circ C$)	120	W
T_J	Operating Junction Temperature Range	-55 to +150	$^\circ C$
T_{STG}	Storage Temperature Range	-55 to +150	$^\circ C$

Thermal Characteristics

Symbol	Parameter	Max.	Units
$R_{th\ j-c}$	Thermal Resistance, Junction to case for IGBT	0.4	$^\circ C/W$
$R_{th\ j-c}$	Thermal Resistance, Junction to case for Diode	0.5	$^\circ C/W$
$R_{th\ j-a}$	Thermal Resistance, Junction to Ambient	40	$^\circ C/W$

Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV_{CES}	Collector-Emitter Breakdown Voltage	$V_{GE}=0V, I_C=250\mu A$	600	-	-	V
I_{CES}	Collector-Emitter Leakage Current	$V_{CE}=600V, V_{GE}=0V$	-	-	100	μA
I_{GES}	Gate Leakage Current, Forward	$V_{GE}=30V, V_{CE}=0V$	-	-	100	nA
	Gate Leakage Current, Reverse	$V_{GE}=-30V, V_{CE}=0V$	-	-	100	nA
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE}=V_{CE}, I_C=250\mu A$	4.5	-	6.5	V
$V_{CE(sat)}$	Collector-Emitter Saturation Voltage	$V_{GE}=15V, I_C=60A$	-	2.4	3.0	V
Q_g	Total Gate Charge	$V_{CC}=400V$ $V_{GE}=15V$ $I_C=60A$	-	115	-	nC
Q_{ge}	Gate-Emitter Charge		-	28	-	nC
Q_{gc}	Gate-Collector Charge		-	42	-	nC
$t_{d(on)}$	Turn-on Delay Time	$V_{CC}=400V$ $V_{GE}=15V$ $I_C=60A$ $R_G=10\Omega$ Inductive Load 100 μH $T_C=25^\circ\text{C}$	-	60	-	ns
t_r	Turn-on Rise Time		-	298	-	ns
$t_{d(off)}$	Turn-off Delay Time		-	100	-	ns
t_f	Turn-off Fall Time		-	146	-	ns
E_{on}	Turn-on Switching Loss		-	5.3	-	mJ
E_{off}	Turn-off Switching Loss		-	1.8	-	mJ
E_{ts}	Total Switching Loss		-	7.1	-	mJ
$t_{d(on)}$	Turn-on Delay Time		$V_{CC}=400V$ $V_{GE}=15V$ $I_C=60A$ $R_G=10\Omega$ Inductive Load 100 μH $T_C=125^\circ\text{C}$	-	56	-
t_r	Turn-on Rise Time	-		256	-	ns
$t_{d(off)}$	Turn-off Delay Time	-		114	-	ns
t_f	Turn-off Fall Time	-		160	-	ns
E_{on}	Turn-on Switching Loss	-		5.7	-	mJ
E_{off}	Turn-off Switching Loss	-		2.4	-	mJ
E_{ts}	Total Switching Loss	-		8.1	-	mJ
C_{ies}	Input Capacitance	$V_{CE}=25V$ $V_{GE}=0V$ $f=1\text{MHz}$		-	2460	-
C_{oes}	Output Capacitance		-	140	-	pF
C_{res}	Reverse Transfer Capacitance		-	34	-	pF

Electrical Characteristics of Diode ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_F	Diode Forward Voltage	$I_F=60A$	-	1.5	2.0	V
t_{rr}	Diode Reverse Recovery Time	$V_{CE}=400V$ $I_F=60A$ $dI_F/dt=200A/\mu s$	-	135	-	ns
I_{rr}	Diode peak Reverse Recovery Current		-	5	-	A
Q_{rr}	Diode Reverse Recovery Charge		-	310	-	nC

Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature

Typical Performance Characteristics

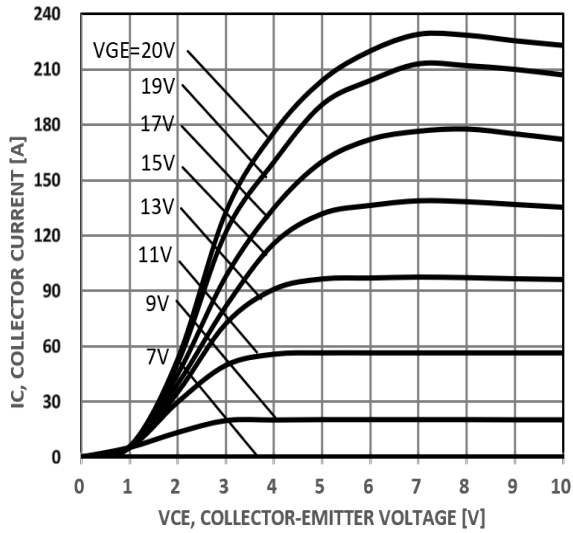


Figure 1. Typical Output Characteristics,
Tc=25°C

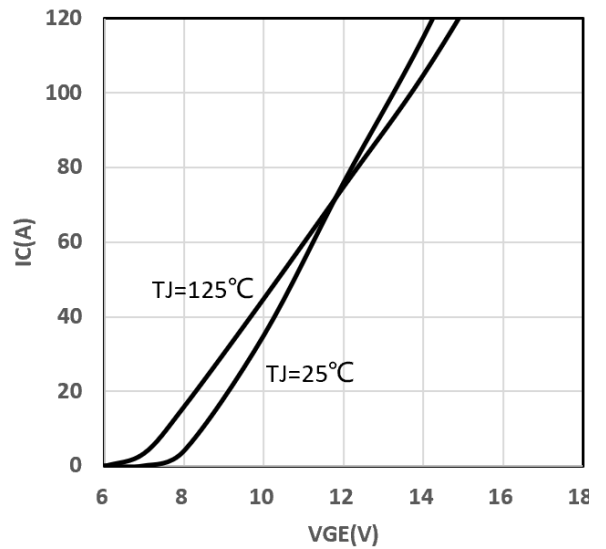


Figure 2. Transfer Characteristics

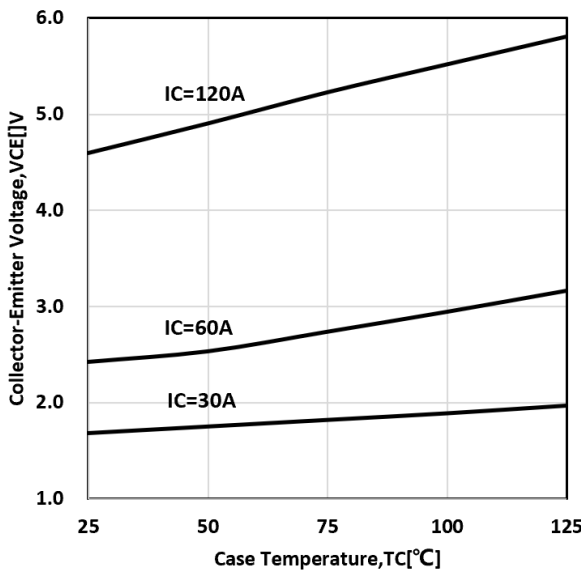


Figure 3. Saturation Voltage
vs. Case Temperature,
Common Emitter, VGE=15V

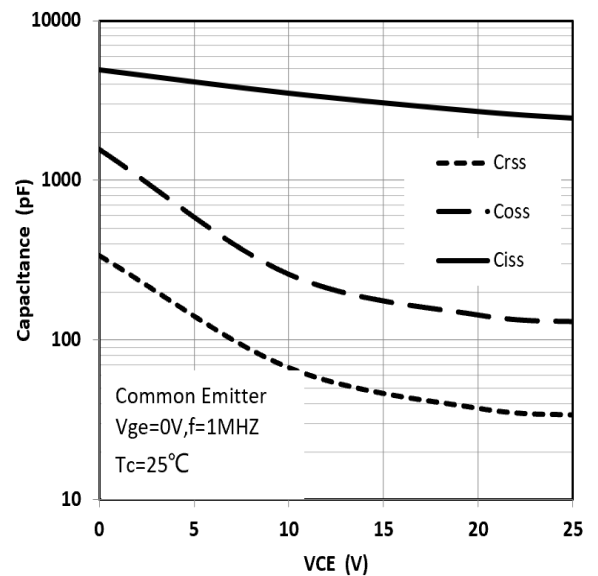


Figure 4. Capacitance Characteristics,
Common Emitter, VGE=0V, f=1MHz, Tc=25°C

Typical Performance Characteristics

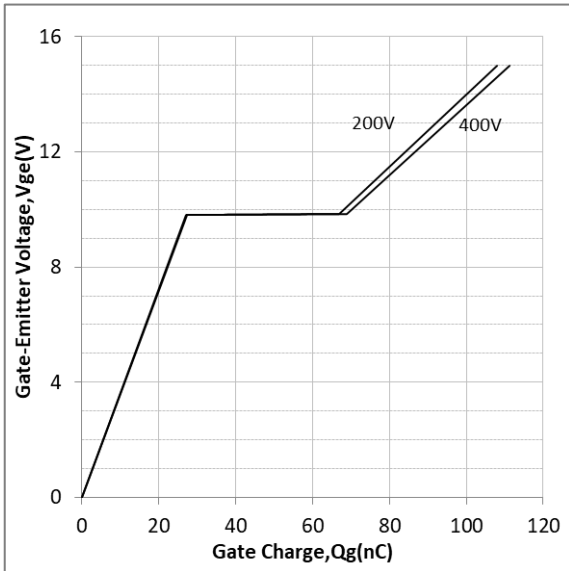


Figure 5. Gate charge Characteristics,
Common Emitter $T_c=25^\circ\text{C}$

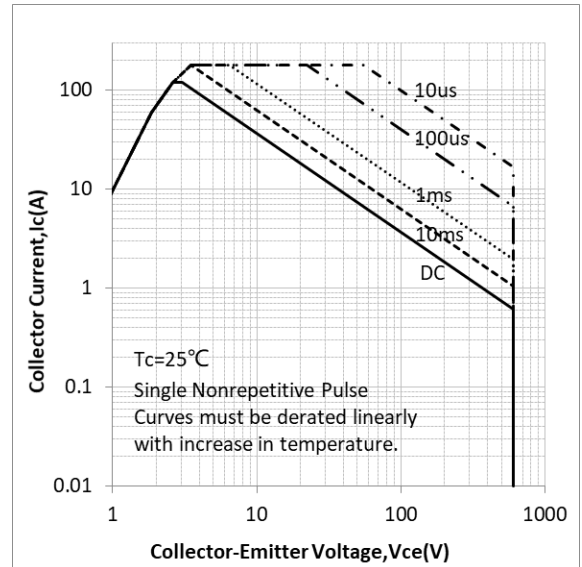


Figure 6. SOA Characteristics

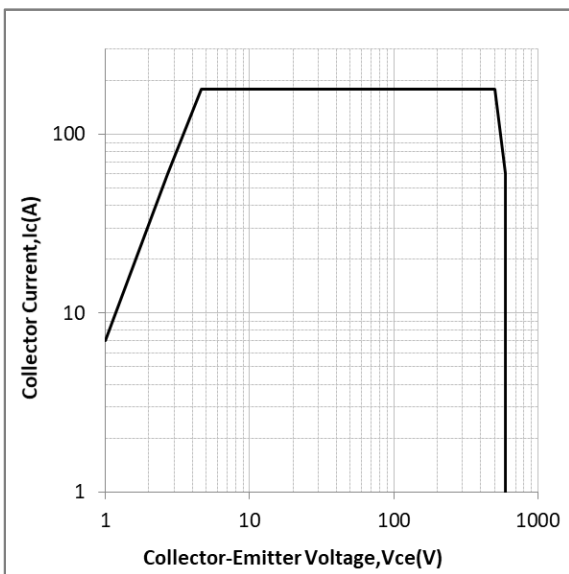


Figure 7. Turn Off Switch SOA
Characteristics , $V_{GE}=15\text{V}$ $T_c=125^\circ\text{C}$

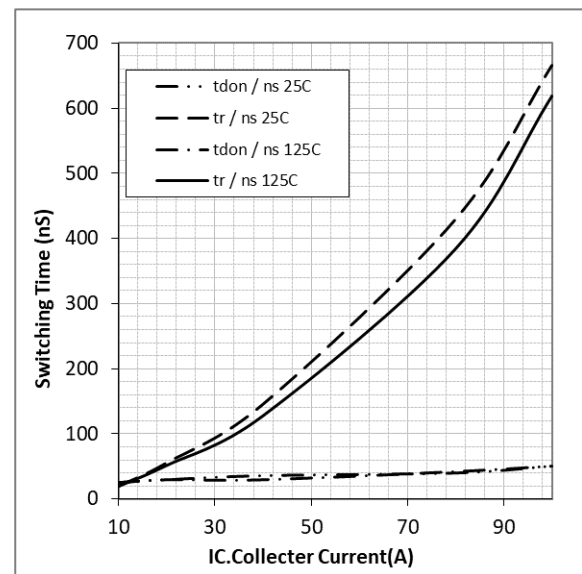


Figure 8. Turn-on Characteristics vs.
Collector Current, Common Emitter
 $V_{ge}=15\text{V}$ $R_G=5\Omega$ $V_{cc}=400\text{V}$

Typical Performance Characteristics

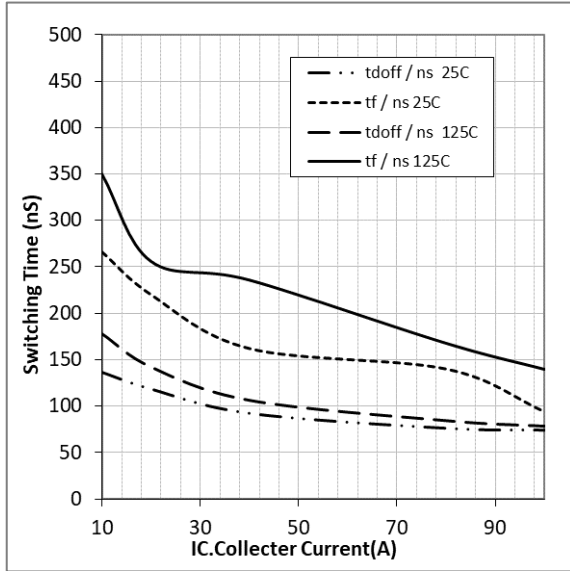


Figure 9. Turn-off Characteristics vs. Collector Current, Comment Emitter
 $V_{ge}=15V$ $R_G=5\Omega$ $V_{cc}=400V$

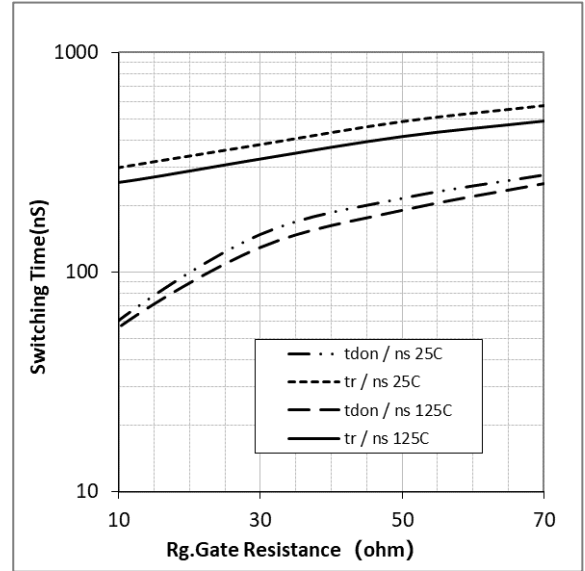


Figure 10. Turn-on Characteristics vs. Gate Resistance, Comment Emitter
 $V_{ge}=15V$ $I_c=60A$ $V_{cc}=400V$

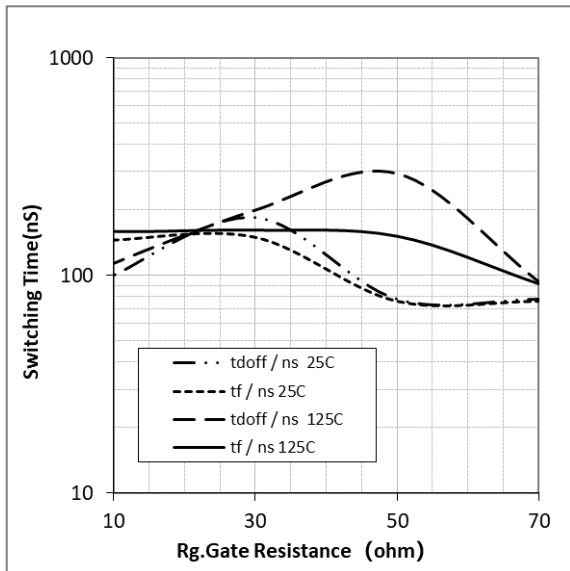


Figure 11. Turn-off Characteristics vs. Gate Resistance, Comment Emitter
 $V_{ge}=15V$ $I_c=60A$ $V_{cc}=400V$

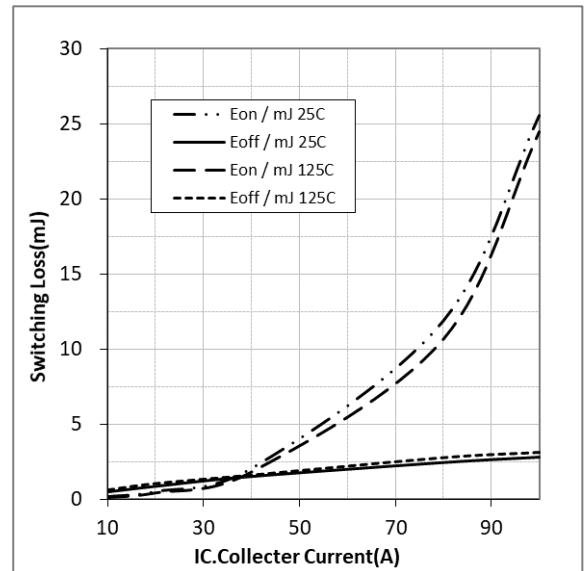


Figure 12. Switch Loss vs Collector Current, Comment Emitter $V_{ge}=15V$
 $V_{cc}=400V$ $R_G=5\Omega$

Typical Performance Characteristics

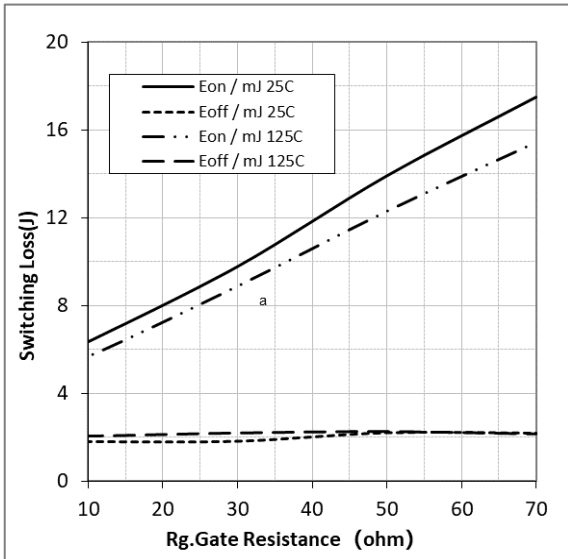


Figure 13. Switch Loss vs Gate Resistance ,
Comment Emitter Vge=15V
Vcc=400V Ic=60A

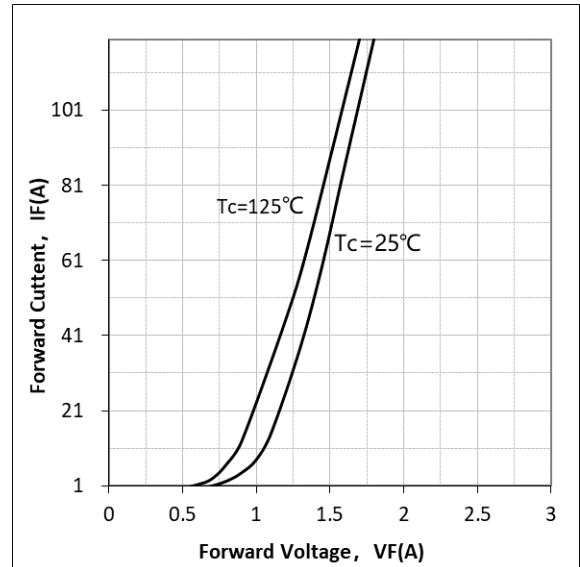


Figure 14. Forward Characteristics

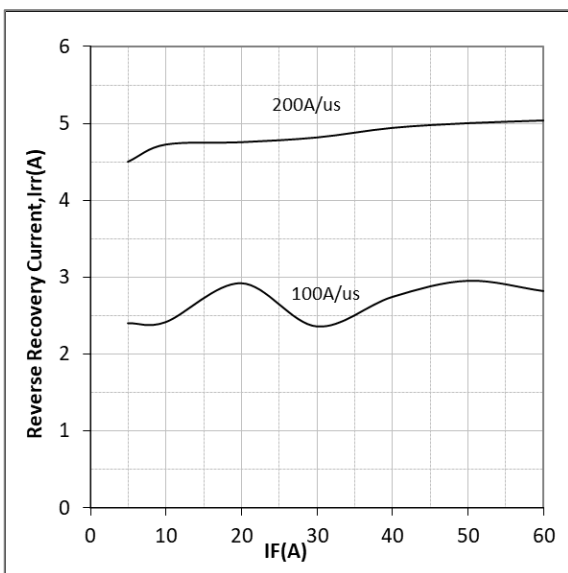


Figure 15. Reverse Recovery Current,
Tc=25°C

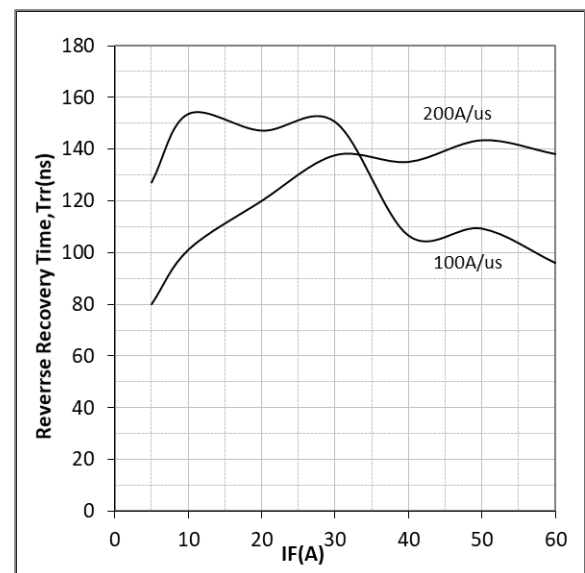


Figure 16. Reverse Recovery Time,
Tc=25°C

Typical Performance Characteristics

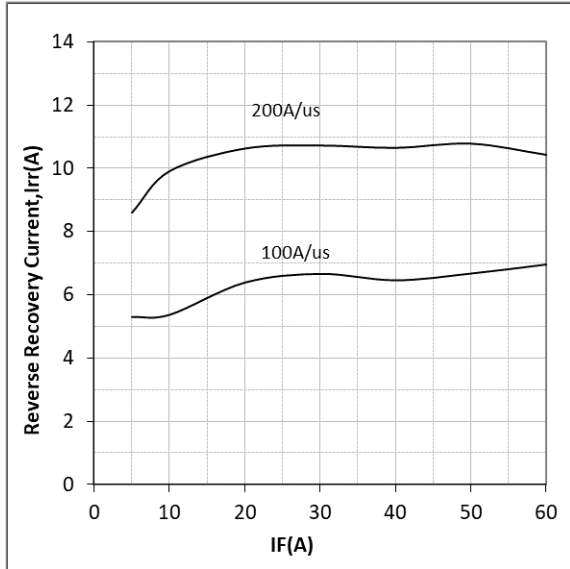


Figure 17. Reverse Recovery Current,
 $T_c=125^\circ\text{C}$

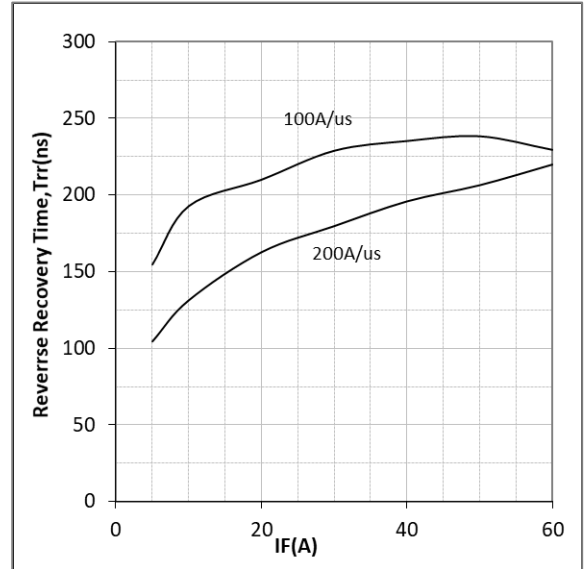


Figure 18. Reverse Recovery Time,
 $T_c=125^\circ\text{C}$

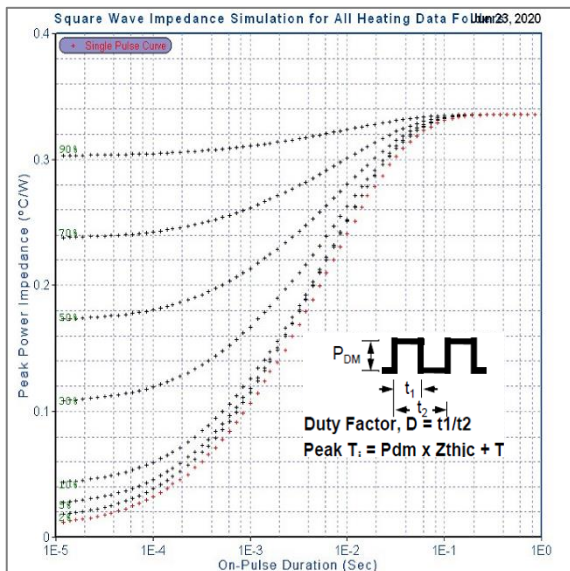


Figure 19. Transient Thermal Impedance of
IGBT

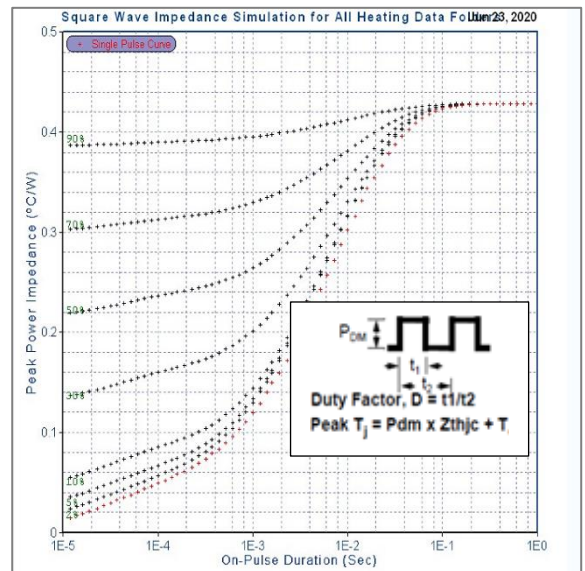
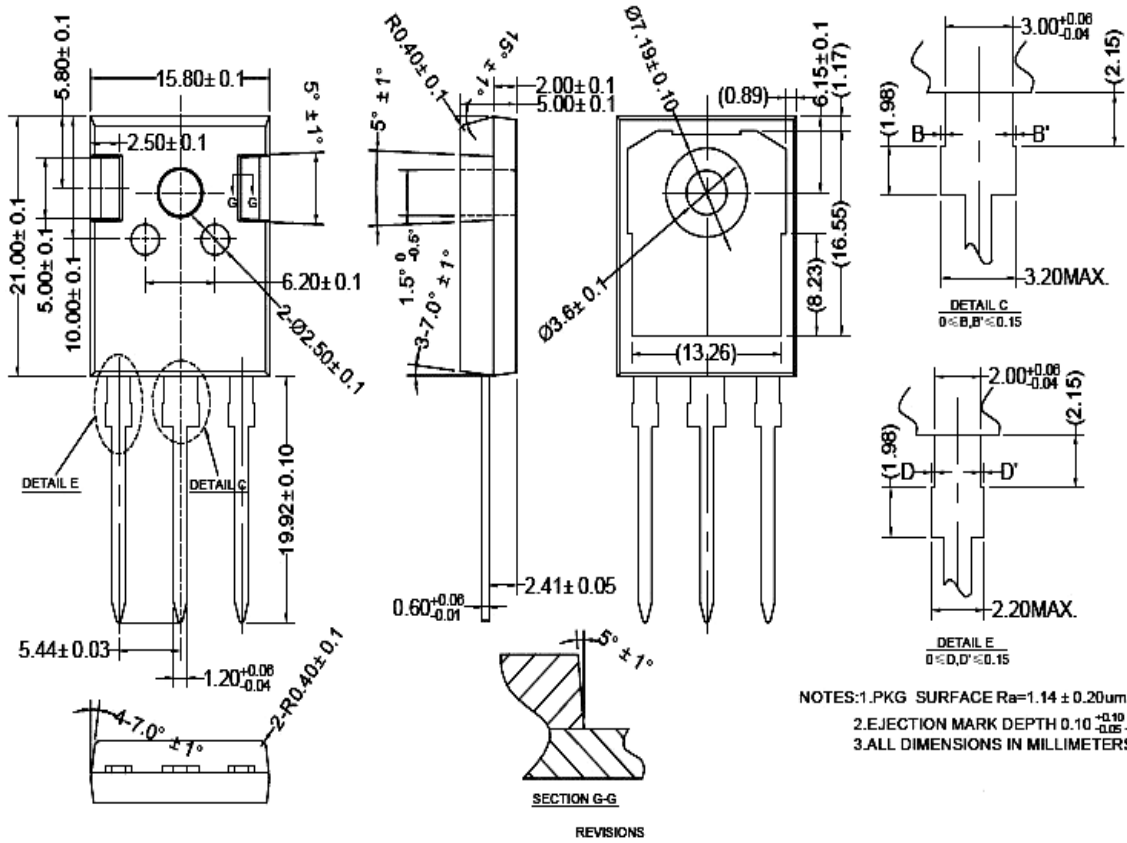


Figure 20. Transient Thermal Impedance of
FRD

TO247 PACKAGE OUTLINE



公差标注	公差值	表面粗糙度
0	±0.2	Ra3.2~6.3
0.0	±0.1	Ra1.6~3.2
0.00	±0.01	Ra0.8~1.6
0.000	±0.005	Ra0.4~0.8
0.0000	±0.002	Ra0.2~0.4

0 ≤ D, D' ≤ 0.15

NOTES: 1. PKG SURFACE Ra=1.14 ± 0.20µm.
2. EJECTION MARK DEPTH 0.10 ^{+0.10}/_{-0.05}
3. ALL DIMENSIONS IN MILLIMETERS.

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